Search Notes



Application/Control	No.	

Applicant(s)/Patent under Reexamination KANG, JUNG-SUN

10/730,237

Art Unit

Examiner

2621

Allen Wong

	SEARCHED				
Class	Subclass	Date	Examiner		
search	updated	11/8/2007	AW		
375	240	11/8/2007	AW		
375	240.01	11/8/2007	AW		
375	240.12	11/8/2007	AW		
375	240.16	11/8/2007	AW		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
375	240.16	11/8/2007	AW	
375	240	11/8/2007	AW	
375	240.01	11/8/2007	AW	
375/2	40.12	11/8/2007	AW	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Gims Philippe (Primary Examiner AU 2621)	11/8/2007	AW
Tommy Chin (QAS TC 2600)	11/8/2007	AW